# R&S®RTA4000 OSCILLOSCOPE

**Specifications** 



Specifications
Version 11.00

ROHDE&SCHWARZ

Make ideas real



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#### **Definitions**

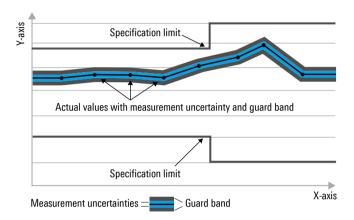
#### Genera

Product data applies under the following conditions:

- Three hours of storage at ambient temperature followed by 30 minutes of warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- · All internal automatic adjustments performed, if applicable

#### Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as <, <, >,  $\ge$ ,  $\pm$  or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



#### Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

#### Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value, e.g. dimensions or resolution of a setting parameter. Compliance is ensured by design.

#### Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

#### Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter, e.g. nominal impedance. In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

#### Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

#### Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bit per second (Gbps), million bit per second (Mbps), thousand bit per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, ksps, ksps and Msample/s are not SI units.

### Base unit

### **Vertical system**

Input channels Input impedance	R&S®RTA4004	4 channels  50 $\Omega$ ± 1.5 % (meas.)		
A	.500:	1 MΩ ± 1 %    14 pF ± 1 pF (meas.)		
Analog bandwidth (–3 dB)	at 50 Ω input impedance			
	R&S®RTA4004	> 200 MHz		
	R&S®RTA4004 with -B243 option	> 350 MHz		
	R&S®RTA4004 with -B245 option	> 500 MHz		
	R&S®RTA4004 with -B2410 option	> 1 GHz		
	at 1 MΩ input impedance			
	R&S®RTA4004 with	> 200 MHz (meas.)		
	R&S®RTA4004 with -B243 option	> 350 MHz (meas.)		
	R&S®RTA4004 with -B245 option	> 500 MHz (meas.)		
	R&S®RTA4004 with -B2410 option	> 500 MHz (meas.)		
Lower frequency limit (-3 dB)	at AC coupling	< 5 Hz (meas.)		
Analog bandwidth limits	at 50 Ω input impedance			
	R&S®RTA4004	20 MHz, 100 MHz		
	R&S®RTA4004 with -B243 option	20 MHz, 100 MHz, 200 MHz		
	R&S®RTA4004 with -B245 option	20 MHz, 100 MHz, 200 MHz, 350 MHz		
	R&S®RTA4004 with -B2410 option	20 MHz, 100 MHz, 200 MHz, 350 MHz,		
	22.10 05.1011	500 MHz		
	at 1 MΩ input impedance			
	R&S®RTA4004	20 MHz, 100 MHz		
	R&S®RTA4004 with -B243 option	20 MHz, 100 MHz, 200 MHz		
	R&S®RTA4004 with -B245 option and	20 MHz, 100 MHz, 200 MHz, 350 MHz		
D: .: ( 1 1 )	R&S®RTA4004 with -B2410 option			
Rise time (calculated)	R&S®RTA4004	< 1.75 ns		
	R&S®RTA4004 with -B243 option	< 1 ns		
	R&S®RTA4004 with -B245 option	< 700 ps		
	R&S®RTA4004 with -B2410 option	< 350 ps		
Vertical resolution		10 bit, up to 16 bit with high resolution decimation		
Invert signal		yes		
DC gain accuracy	offset and position = 0			
	maximum operating temperature change of ±5 °C after self-alignment			
	input sensitivity > 5 mV/div	±1 %		
	input sensitivity	±1.5 %		
	≤ 5 mV/div to ≥ 1 mV/div			
	input sensitivity < 1 mV/div	±2.5 %		
Input coupling	par contentity 1 mm/an	DC, AC (> 7 Hz)		
Input sensitivity	at 50 Ω	0.5 mV/div to 1 V/div		
input solisitivity	at 1 MΩ	0.5 mV/div to 1 V/div		
Maximum input valtage				
Maximum input voltage	at 50 Ω	5 V (RMS), max. 30 V (V <sub>p</sub> )		
	at 1 MΩ	300 V (RMS), 400 V (V <sub>p</sub> ), derates at		
		20 dB/decade to 5 V (RMS) above		
		250 kHz		
Position range		±5 div		
Offset range at 50 Ω	input sensitivity			
	≥ 112 mV/div to 1 V/div	±(30 V − 5 div × input sensitivity)		
	≥ 33.8 mV/div to 111 mV/div	±(10 V − 5 div × input sensitivity)		
	0.5 mV/div to 33.6 mV/div	±(2 V − 5 div x input sensitivity)		
Offset range at 1 MΩ	input sensitivity			
	≥ 515 mV/div to 10 V/div	±(250 V − 5 div × input sensitivity)		
	≥ 50.5 mV/div to 510 mV/div	±(25 V − 5 div × input sensitivity)		
	0.5 mV/div to 50 mV/div	±(2 V – 5 div × input sensitivity)		
Offset accuracy		±(0.5 % ×  offset  +		
Chiest doodrady		0.1 div × input sensitivity + 0.5 mV)		
DC measurement accuracy	after adequate suppression of	±(DC gain accuracy ×  reading - net		
DC measurement accuracy	measurement noise by using either high-	offset + offset accuracy)		
		onset + onset accuracy)		
	resolution sampling mode or waveform			
	averaging, or a combination of both			
Channel-to-channel isolation	input frequency < analog bandwidth	> 50 dB		

RMS noise floor at 1 MΩ (meas.)	Input sensitivity	R&S®			
	,	RTA4004	RTA4004 with	RTA4004 with	RTA4004 with
			-B243 option	-B245 option	-B2410 option
	10 V/div	271 mV	300 mV	370 mV	370 mV
	5 V/div	161 mV	172 mV	230 mV	230 mV
	2 V/div	64 mV	70 mV	100 mV	100 mV
	1 V/div	38 mV	43 mV	60 mV	60 mV
	500 mV/div	16 mV	17 mV	23 mV	23 mV
	200 mV/div	6 mV	7 mV	10 mV	10 mV
	100 mV/div	3.6 mV	4.1 mV	5.80 mV	5.80 mV
	50 mV/div	1.6 mV	1.6 mV	2.10 mV	2.10 mV
	20 mV/div	0.7 mV	0.8 mV	1.10 mV	1.10 mV
	10 mV/div	0.4 mV	0.4 mV	0.60 mV	0.60 mV
	5 mV/div	0.21 mV	0.25 mV	0.33 mV	0.33 mV
	2 mV/div	0.14 mV	0.18 mV	0.24 mV	0.24 mV
	1 mV/div	0.13 mV	0.14 mV	0.18 mV	0.18 mV
	0.5 mV/div	0.12 mV	0.13 mV	0.17 mV	0.17 mV
RMS noise floor at 50 Ω (meas.)	Input sensitivity	R&S®			
		RTA4004	RTA4004 with	RTA4004 with	RTA4004 with
			-B243 option	-B245 option	-B2410 option
	1 V/div	27 mV	27 mV	30 mV	38.0 mV
	500 mV/div	15 mV	16 mV	18 mV	24.0 mV
	200 mV/div	8 mV	9 mV	10 mV	13.0 mV
	100 mV/div	3.2 mV	3.6 mV	4.1 mV	5.50 mV
	50 mV/div	1.7 mV	1.9 mV	2.2 mV	2.90 mV
	20 mV/div	0.7 mV	0.8 mV	0.8 mV	1.10 mV
	10 mV/div	0.3 mV	0.3 mV	0.4 mV	0.50 mV
	5 mV/div	0.18 mV	0.22 mV	0.24 mV	0.33 mV
	2 mV/div	0.08 mV	0.11 mV	0.12 mV	0.16 mV
	1 mV/div	0.08 mV	0.09 mV	0.1 mV	0.14 mV
	0.5 mV/div	0.06 mV	0.08 mV	0.1 mV	0.13 mV

### **Horizontal system**

Timebase range		selectable between
_		0.5 ns/div and 500 s/div
Channel deskew		±500 ns
Trigger offset range	minimum	memory depth
		actual sampling rate
	maximum	2 <sup>33</sup>
		actual sampling rate
Modes		normal, roll
Channel-to-channel skew		< 200 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±0.5 ppm
	during calibration interval	±1.5 ppm
Delta time accuracy	corresponds to time error between to	±(1.34/Fs + timebase accuracy ×
	edges on same acquisition and channel;	reading ) (peak) (meas.)
	waveform sample rate Fs can be obtained	
	<pre>via SCPI command "ACQ:SRAT?";</pre>	
	signal amplitude greater than 5 divisions,	
	measurement threshold set to 50 %,	
	vertical gain 10 mV/div or greater;	
	rise time lower than 4/Fs;	
	waveform acquired in sample mode	

### **Acquisition system**

Maximum realtime sampling rate	normal mode	2.5 Gsample/s
	interleaved mode,	5 Gsample/s
	if following channels are not used	
	simultaneously:	
	<ul> <li>channel 1 and channel 2</li> </ul>	
	<ul> <li>channel 3 and channel 4</li> </ul>	
	<ul> <li>D15 to D8 and D7 to D0 (logic</li> </ul>	
	channels)	
Memory depth per channel	normal mode	100 Msample per channel
	interleaved mode,	200 Msample per channel
	if following channels are not used	
	simultaneously:	
	channel 1 and channel 2	
	channel 3 and channel 4      Day 1 Da	
	D15 to D8 and D7 to D0 (logic channels)	
Acquisition modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation
		interval (400 ps detection)
	high resolution	average value of all samples in decimation interval
	envelope	envelope of acquired waveforms
	average	average over a series of acquired waveforms
	envelope + peak detect	envelope of acquired waveforms with active peak detect
	envelope + high resolution	envelope of acquired waveforms with active high resolution
	average + high resolution	average over a series of acquired high resolution waveforms
Number of averaged waveforms		2 to 100 000
Waveform acquisition rate	dot display, single channel, auto record length	up to 64 000 waveforms/s

### **Trigger system**

Trigger level	range	±5 div from center of screen
Trigger modes		auto, normal, single, n single
Hold-off range	time	inactive or 51.2 ns to 13.7 s
Trigger types		edge, width, video, pattern, runt, rise time, fall time, serial bus, line, timeout
	actions on trigger	pulse, sound, screenshot, save waveform, save reference waveform
Edge trigger A	trigger events	rising edge, falling edge, both edges
3 33	R&S <sup>®</sup> RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option), external trigger input
	trigger coupling	DC, AC (attenuates < 10 Hz (meas.)), LF reject (attenuates < 10 kHz (meas.))
	trigger filter	HF reject (attenuates > 100 kHz (meas.)), noise reject (attenuates > 100 MHz (meas.))
	selectable trigger hysteresis	automatic, small, medium, large

Trigger A sensitivity hysteresis mode	with DC, AC, LF reject, noise reject	
automatic	1 GHz, 500 MHz, 350 MHz	$2.2  mV_{nn}$
	, ,	$> \frac{2.2  mV_{pp}}{input  sensitivity} + 1  div  (nom.)$
		(input sensitivity: [mV/div])
		(input sensitivity, [inv/div])
	200 MHz, 100 MHz	$1.5  mV_{nn}$
	,	$> \frac{1.5  mV_{pp}}{input  sensitivity} + 0.8  div  (nom.)$
		(input sensitivity: [mV/div])
	20.181	
	20 MHz	$> \frac{0.6  mV_{pp}}{input  sensitivity} + 0.4  div  (nom.)$
		input sensitivity (nont.)
		(input sensitivity: [mV/div])
	with HF reject	
	all input sensitivities	1 div (meas.)
Edge trigger A and B	trigger events	rising edge, falling edge, both edges
	sources for A trigger	
	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0
		(with R&S®RTA-B1 option)
	trigger coupling of A trigger	DC
	sources for B trigger	
	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0
		(with R&S®RTA-B1 option)
	trigger coupling of B trigger	DC
	selectable trigger hysteresis for A and B	small, medium, large
	trigger	, g
	trigger B mode	after time or after events
	trigger B minimum time	3.2 ns
	trigger B maximum time	100 s
	trigger B events	1 to 65535
Width trigger	trigger events	pulse width is smaller, greater, equal,
Tridar anggor	ingger evente	unequal, inside interval, outside interval
	minimum pulse width	3.2 ns
	maximum pulse width	6.8 s
	polarity	positive, negative
	sources	positive, negative
	R&S®RTA4004	channel 1, channel 2, channel 3,
	100 1174004	channel 4, logic channels from D15 to D0
		(with R&S®RTA-B1 option)
	selectable trigger hysteresis	
Timeout trigger	trigger events	small, medium, large greater than timeout
Timeout trigger	minimum timeout	3.2 ns
	maximum timeout	
		6.8 s
	polarity	stays high, stays low
	SOURCES De Contra 4004	abannal 1. abannal 2. abannal 2
	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0
	a da atable triangula bustons de	(with R&S®RTA-B1 option)
Nidos triarros	selectable trigger hysteresis	small, medium, large
Video trigger	trigger events	selectable line, all lines, even frame,
	account of atom double	odd frame, all frames
	supported standards	PAL, NTSC, SECAM, PAL-M, SDTV 576i,
		HDTV 720p, HDTV 1080i, HDTV 1080p
	Sources	
	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, ext. trigger input
	sync pulse polarity	positive, negative

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Pattern trigger	trigger events	logic condition between active channels	
	sources	· •	
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)	
	state of channels	high, low, don't care	
	logic between channels	and/or	
	condition	true, false	
	duration condition	smaller, greater, equal, unequal, inside interval, outside interval, timeout	
	minimum duration time	3.2 ns	
	maximum duration time	6.8 s	
Runt trigger		triggers on pulse of positive, negative or either polarity that crosses one threshold but fails to cross a second threshold before crossing the first one again	
Rise time, fall time	trigger events	time between the crossing of two selectable levels is smaller, greater, equal, unequal, inside interval, outside interval	
	minimum rise time	3.2 ns	
	maximum rise time	6.8 s	
	polarity	rising edge, falling edge, both edges	
	sources		
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4	
Serial bus trigger	supported standards		
	R&S®RTA-K1 option	I <sup>2</sup> C, SSPI (two-wire, MOSI/MISO), SPI (three-wire, MOSI/MISO)	
	R&S®RTA-K2 option	UART/RS-232/RS-422/RS-485 (RX/TX)	
	R&S®RTA-K3 option	CAN/LIN	
	R&S®RTA-K5 option	audio (I <sup>2</sup> S, LJ, RJ, TDM)	
	R&S®RTA-K6 option	MIL-STD-1553	
	R&S®RTA-K7 option	ARINC 429	
External trigger input	input impedance	$1 M\Omega \pm 1 \%$ with 14 pF $\pm 2$ pF (meas.)	
	maximum input voltage at 1 $M\Omega$	300 V (RMS), 400 V ( $V_p$ ), derates at 20 dB/decade to 5 V (RMS) above 250 kHz	
	trigger level	±5 V	
	sensitivity	> 300 mV (V <sub>pp</sub> )	
	coupling	DC, AC, LF reject	
Trigger output	functionality	A pulse is generated for every acquisition trigger event.	
	output voltage		
	at high impedance	0 V to 4.8 V	
	at 50 Ω	0 V to 2.4 V	
	pulse polarity	high active	

### **Waveform measurements**

Automatic measurements	measurements on channels, math waveforms, reference waveforms	burst width, count positive pulses, count negative pulses, count falling edges, count rising edges, mean value, RMS cycle, RMS, mean cycle, peak peak, peak+, peak-, frequency, period, amplitude, top level, base level, positive overshoot, negative overshoot, pulse width+, pulse width-, duty cycle+, duty cycle-, rise time, fall time, delay, phase, crest factor, slew rate+, slew rate-, σ.std. deviation, σ.std. deviation cycle, delay to trigger
	reference levels	lower, middle and upper level in percentage
	statistics	maximum, minimum, mean, standard deviation and measurement count for each automatic measurement
	number of active measurements	8
Cursor measurements	type	vertical, horizontal, vertical and horizontal, V-marker
	functions	x and y tracking, coupling of cursors, set to trace, two sources selectable
Quick measurements	function	fast overview of measurements from one channel, some measurements displayed with result lines in diagram
	sources	
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4
	measurements displayed in diagram	mean, max. peak, min. peak, rise time, fall time
	numerically displayed measurements	RMS cycle, peak-to-peak voltage, period, frequency

# **Digital voltmeter**

Accuracy		related to channel settings of voltmeter
		source
Measurements		DC, AC+DC RMS, AC RMS
Sources	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4
Number of measurements		up to 4
Resolution		up to 3 digits
Bandwidth		1 MHz

#### Counter

Measurements		frequency, period
Sources	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, trigger signal source
Number of measurements		2
Resolution		7 digits
Frequency range		0.05 Hz to bandwidth of oscilloscope
		(limited by bandwidth of trigger filter)

### **Mask testing**

Sources	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4
Mask definition		acquired waveform with user-defined tolerance, can be stored and restored
Result statistics		completed acquisitions, passed and failed acquisitions (absolute and in percent), test duration
Actions on mask violation		sound, acquisition stop, screenshot, save waveform, pulse out (AUX OUT connector)
Captured segments		all segments, failed segments

#### **Waveform maths**

Number of math equations		up to 5
Functions		addition, subtraction, multiplication,
		division, square, square root, absolute
		value, reciprocal, inverse, log10, ln,
		derivation, integration, low pass, high
		pass, track period, track frequency, track
		pulse width, track duty cycle
	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, math waveforms 1 to 4

# Fast Fourier transform (FFT)

Sources	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4, math waveforms, references
Setup parameters		start frequency, stop frequency, center frequency, frequency span, vertical scale, vertical position, resolution bandwidth, gate (time range and position)
Windows		Hanning, Hamming, Blackman, rectangular, flat top
Waveform arithmetic		none, min. hold, max. hold, average (selectable 2 to 1024)
Scaling		dBm, dBV, dBμV, V (RMS)

#### **Search function**

Functions	search types	edge, width, peak, rise/fall time, runt, data2clock, pattern, window, protocol (available with R&S®RTA-K3, R&S®RTA-K6 and R&S®RTA-K7 options)
	configuration	manual level setting on screen, level with selectable hysteresis
	display of search events	up to 10 000 events in diagram and in result table
	markers on search events	up to 32 markers
	navigation in search events (stop mode)	knob (if result table is active)
Sources	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, math waveforms from 1 to 5,
		D15 to D0 (with R&S®RTA-B1 option)

### **Display characteristics**

Diagram types	manually changeable vertical window size	Yt, XY, zoom, FFT, spectrogram (with R&S®RTA-K37 option)
XY mode		parallel display of XY diagram and Yt diagrams of input signals for X, Y
Zoom		horizontal and vertical zoom, split screen with overview signal and zoomed signal
Interpolation		sin(x)/x, linear, sample & hold
FFT mode		split screen with Yt diagrams and
		dedicated frequency diagram,
		spectrogram (with R&S®RTA-K37 option)
Waveform display		lines, dots only
Persistence		50 ms to 12.8 s; infinite
Special display mode		inverse brightness, waveform color modes
		for analog channels (temperature, fire,
		rainbow)
Diagram grid		lines, reticle, none, with annotation, track
		grid
Reference signals		up to 4 reference signals

### **Protocol and logic**

Bus decode	number of bus signals	4 1
	bus types	parallel, parallel clocked
	R&S®RTA-K1 option	SSPI, SPI, I <sup>2</sup> C
	R&S®RTA-K2 option	UART/RS-232/RS-422/RS-485
	R&S®RTA-K3 option	CAN, LIN
	R&S®RTA-K5 option	I <sup>2</sup> S, LJ, RJ, TDM
	R&S®RTA-K6 option	MIL-STD-1553
	R&S®RTA-K7 option	ARINC 429
	display types	decoded bus, logical signal,
		frame table (depends on decoded bus)
	position and size	size and position on screen selectable
	data format of decoded bus	hex, decimal, binary, octal, ASCII

### History and segmented memory

	-			
Acquisition memory		automatic, predef	ined, manual	
	automatic	automatic segme	automatic segment size and numbers	
	predefined	defined size and	defined size and automatic numbers	
	manual	user-defined size	and numbers	
Memory segmentation	function	memory segment	s for the acquisition	
	number of segments 2	record length	segments	total memory
			(up to)	(per channel)
		5 ksample	87 380	436.9 Msample
		10 ksample	87 380	873.8 Msample
		20 ksample	43 690	873.8 Msample
		50 ksample	17 476	873.8 Msample
		100 ksample	9 708	970.8 Msample
		200 ksample	5 140	1028 Msample
		500 ksample	2 131	1065.5 Msample
		1 Msample	1 065	1065 Msample
		2 Msample	536	1072 Msample
		5 Msample	214	1070 Msample
		10 Msample	107	1070 Msample
		20 Msample	53	1060 Msample
		50 Msample	21	1050 Msample
		100 Msample	10	1000 Msample
		200 Msample	5	1000 Msample
	Segmentation is active	on all analog and lo	ogic channels, proto	
	spectrum analysis.	J	71	Ŭ

 $<sup>^{\</sup>rm 1}$  If a bidirectional bus is used (e.g. UART RX/TX or SPI MOSI/MISO), two bus decoders are occupied.

<sup>&</sup>lt;sup>2</sup> At interleaved mode.

Fast-segmented mode		of waveforms in acquisition memory without interruption due to be between consecutive acquisitions less than 200 ns (up to s)	
History mode	function	function  The history mode always provides access to past acquisiti in the segmented memory.	
	timestamp resolution	3.2 ns	
	history player	replays the recorded waveforms; repetition possible; adjustable speed; manual next/previous segment; numerical segment number input	
	analyze options	overlay all segments, average all segments, envelope all segments	

### **Miscellaneous**

Save/recall	device settings	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
	reference waveforms	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
	waveforms	save on USB memory stick or download and save on a PC via web interface or USB-MTP, available file formats: BIN, CSV, TXT float (MSB/LSB first)
	screenshots	save on USB memory stick or download and save on a PC via web interface or USB-MTP, available file formats: BMP, PNG
	device settings	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
Camera key		configurable camera key, actions on press:
	save screenshot	one-touch off
	one-touch	one or more from the list:     setup     screenshots (PNG, color)     waveforms (BIN-MSB, CI, display data)     references     search event table     bus table     statistics
Instrument security		secure erasure of internal file system and all settings
Menu languages		available menu languages:  English German French Spanish Italian Portuguese Czech Polish Russian Simplified Chinese Traditional Chinese Korean Japanese
Help		online help, available languages:  • English
Undo/Redo		deep Undo/Redo function

### Input and outputs

Front		
Channel inputs		BNC, for details see Vertical system
	probe interface	auto detection of passive probes,
		Rohde & Schwarz active probe interface
External trigger input		BNC, for details see Trigger system
	probe interface	auto detection of passive probes
Waveform generator		BNC, for details see R&S®RTA-B6,
(requires R&S®RTA-B6 option)		waveform generator,
		demo lug and GND lug
Probe compensation output	signal shape	rectangle
	frequency	1 kHz
	voltage	$V_{low} = 0 \text{ V}, V_{high} = 1.5 \text{ V to } 3.3 \text{ V (meas.)}$
Pattern source (requires R&S®RTA-B6 option)	P3 to P0	4 lugs, for details see R&S®RTA-B6,
		4-bit pattern generator
	frequency	1 mHz to 25 MHz
	voltage	$V_{low} = 0 \text{ V}, V_{high} = 1.5 \text{ V to } 3.3 \text{ V (meas.)}$
Ground lug		connected to ground
USB host interface		1 port, type A plug, version 2.0,
		USB drives only, FAT32 formatting
		required
Rear		
Ethernet interface		1 port, 1 Gbit
AUX OUT (BNC)	trigger out,	for details see Trigger system
	reference frequency	10 MHz ±3.5 ppm (meas.)
	mask violation	pulse
USB device interface		1 port, type B plug, version 2.0
Fixation loop		for securing the instrument with a cable
Security slot		for standard Kensington style lock
Right side		
Digital channel inputs	D15 to D8, D7 to D0	requires R&S®RTA-B1 option

### **General data**

Type
Temperature   Operating temperature range
Temperature loading
Storage temperature range
425 °C/+40 °C at 85 % rel. humidity cyclin line with IEC 60068-2-30
In line with IEC 60068-2-30
Altitude
Up to 3000 m above sea level
Nonoperating
Nonoperating
Sinusoidal   Sin
Vibration         sinusoidal         5 Hz to 150 Hz, max. 1.8 g at 55 Hz; o 150 Hz, in line with EN 60068-2-6 MIL-PRF-28800F, 4.5.5.3.2 sinusoidal vibration, class 3 and 4           random         8 Hz to 500 Hz, acceleration 1.2 g (RMS), in line with EN 60068-2-64, MIL-PRF-28800F, 4.5.5.3.1 random vibration, class 3 and 4           Shock         40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine           EMC           RF emission         in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 class A, making the instrument outsibale for use in industrial environments           Immunity         in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3 VDE, cGSAus, KC           Certifications         100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A           Power consumption         max. 160 W
0.5 g from 55 Hz to 150 Hz, in line with EN 60068-2-6
In line with EN 60068-2-6   MIL-PRF-28800F, 4.5.5.3.2 sinusoidal vibration, class 3 and 4   random
MIL-PRF-28800F, 4.5.5.3.2 sinusoidal vibration, class 3 and 4
random  Reference of the process of
random  8 Hz to 500 Hz, acceleration 1.2 g (RMS), in line with EN 60068-2-64, MIL-PRF-28800F, 4.5.5.3.1 random vibration, class 3 and 4  40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments  Certifications  VDE, cCSA <sub>US</sub> , KC Calibration interval Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A Power consumption  max. 160 W
acceleration 1.2 g (RMS), in line with EN 60068-2-64, MIL-PRF-28800F, 4.5.5.3.1 random vibration, class 3 and 4  Shock  40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  VDE, cCSA <sub>US</sub> , KC Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
in line with EN 60068-2-64, MIL-PRF-28800F, 4.5.5.3.1 random vibration, class 3 and 4  Shock  40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSA <sub>US</sub> , KC Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
MIL-PRF-28800F, 4.5.5.3.1 random vibration, class 3 and 4  Shock  40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSAus, KC Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
vibration, class 3 and 4  Shock  40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSAus, KC  Calibration interval  Power supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
Shock  40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSAus, KC Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
in line with MIL-STD-810E, method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSAUS, KC  Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
method no. 516.4, procedure I, MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications  Certifications  Certification interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
MIL-PRF-28800F, 4.5.5.4.1 functional shock, 30 g, 11 ms, halfsine  EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emission requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSAUS, KC  Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
EMC  RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emission requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSA <sub>US</sub> , KC  Calibration interval  1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
RF emission  in line with CISPR 11/EN 55011 group 1 class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments 3  Certifications  Certifications  VDE, cCSA <sub>US</sub> , KC  Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
class A (for a shielded test setup); the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications  VDE, cCSA <sub>US</sub> , KC  Calibration interval 1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
the instrument complies with the emissio requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments  Certifications  VDE, cCSAus, KC  Calibration interval  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications VDE, cCSA <sub>US</sub> , KC Calibration interval 1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption max. 160 W
requirements stipulated by EN 55011, EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications VDE, cCSA <sub>US</sub> , KC Calibration interval 1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption max. 160 W
EN 61326-1 and EN 61326-2-1 class A, making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications  VDE, cCSA <sub>US</sub> , KC  Calibration interval  1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
making the instrument suitable for use in industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications  VDE, cCSA <sub>US</sub> , KC  Calibration interval  1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
industrial environments  Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications  VDE, cCSA <sub>US</sub> , KC  Calibration interval 1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
Immunity  in line with IEC/EN 61326-1 table 2, immunity test requirements for industrial environments <sup>3</sup> Certifications  VDE, <sub>C</sub> CSA <sub>US</sub> , KC  Calibration interval  1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
immunity test requirements for industrial environments <sup>3</sup> Certifications  VDE, cCSA <sub>US</sub> , KC  Calibration interval  1 year  Power supply  AC supply  100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption  max. 160 W
Environments 3
Certifications         VDE, cCSA <sub>US</sub> , KC           Calibration interval         1 year           Power supply         100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A           Power consumption         max. 160 W
Calibration interval         1 year           Power supply         100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A           Power consumption         max. 160 W
Power supply           AC supply         100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A           Power consumption         max. 160 W
AC supply 100 V to 240 V at 50 Hz to 60 Hz, 1.6 A to 0.7 A  Power consumption max. 160 W
Power consumption 1.6 A to 0.7 A max. 160 W
Power consumption max. 160 W
Safety in line with
• IEC 61010-1, IEC 61010-2-030
• EN 61010-1, EN 61010-2-030
• CAN/CSA-C22.2 No. 61010-1
• CAN/CSA-C22.2 No. 61010-2-030
• UL 61010-1, UL 61010-2-030
Mechanical data
Dimensions $W \times H \times D$ 390 mm $\times$ 220 mm $\times$ 152 mm
$(15.35 \text{ in} \times 8.66 \text{ in} \times 5.98 \text{ in})$
,
Weight without options (nom.) 3.3 kg (7.275 lb)
Weightwithout options (nom.)3.3 kg (7.275 lb)Audible noisemaximum sound pressure level at a28.3 dB(A)

 $<sup>^3</sup>$  Test criterion is displayed noise level within  $\pm 1$  div for input sensitivity of 5 mV/div.

# **Options**

#### R&S®RTA-B1

Vertical system Input channels		16 logic channels (from D15 to D0)
Arrangement of input channels		arranged in two logic probes with 8 channels each, assignment of the logic probes to the channels D15 to D8 and D7 to D0
Input impedance		100 kΩ ± 2 %    ~4 pF (meas.) at probe tips
Maximum input frequency	signal with minimum input voltage swing and hysteresis setting: normal	400 MHz (meas.)
Maximum input voltage	•	±40 V (V <sub>p</sub> )
Minimum input voltage swing		500 mV (V <sub>pp</sub> ) (meas.)
Threshold groups		from D15 to D12, D11 to D8, D7 to D4 and D3 to D0
Threshold level	user range	±8 V in 25 mV steps
	predefined	CMOS 2.5 V, TTL 1.4 V, ECL -1.3 V
Threshold accuracy	threshold setting between ± 4 V	±(100 mV + 3 % of threshold setting)
Comparator hysteresis		small, medium, large
Horizontal system		
Channel deskew	range for each channel	±500 ns
Channel-to-channel skew		< 200 ps (meas.) for same vertical settings on the channels
Acquisition system		'
Sampling rate	two logic probes (normal mode)	2.5 Gsample/s on each channel
	one logic probe (interleave mode)	5 Gsample/s on each channel
Memory depth	two logic probes (normal mode)	100 Msample for every channel
, ,	one logic probe (interleave mode)	200 Msample for every channel
Trigger system		see chapter Trigger system of the base unit
Waveform measurements		'
Measurement sources		all channels from D15 to D0
Automatic measurements		positive pulse width, negative pulse width, period, frequency, burst width, delay, phase, positive duty cycle, negative duty cycle, positive pulse count, negative pulse count, rising edge count, falling edge count
Additional cursor function		display of hex. value at the cursor position
Display characteristics		
Channel activity display		independent of the oscilloscope acquisition, the state (stays low, stays hig or toggles) of the channels from D15 to Di is displayed

### R&S®RTA-B6

Waveform generator and 4-bit patter	ii generator	
Waveform generator		14 bit
Resolution		
Sample rate		250 Msample/s
Output impedance	I second	50 Ω ±1 % (meas.)
Amplitude	level	
	in to high Z	20 mV to 10 V (V <sub>pp</sub> )
	in to 50 Ω	10 mV to 5 V (V <sub>pp</sub> )
	accuracy (frequency ≤100 kHz)	1.5 %
DC offset	level	
	in to high Z	± 5 V
	in to 50 $\Omega$	± 2.5 V
	accuracy	1.5 % or ±3 mV whatever is greater
Sine	frequency	0.1 Hz to 25 MHz
	SFDR	> 40 dBc (meas.)
	THD	> 40 dBc (meas.)
Rectangle	frequency	0.1 Hz to 10 MHz
Pulse	frequency	0.1 Hz to 10 MHz
	edge time	adjustable
	duty cycle	1 % to 99 %
Ramp, triangle, sinc, exponential	frequency	0.1 Hz to 1 MHz
		0.1 Hz to 10 MHz
Arbitrary	frequency	
	memory depth	32k point
Noise	bandwidth	max. 25 MHz
	level	0 to 100 % of signal amplitude
Modulation	AM	
	function	sine, rectangle, triangle, ramp
	frequency	0.1 Hz to 1 MHz
	depth	0 to 100 %
	FM	
	function	sine, rectangle, triangle, ramp
	frequency	0.1 Hz to 1 MHz
	deviation	depends on modulation frequency
	ASK	depends on modulation requestoy
	function	sine, rectangle, triangle, ramp
		0.1 Hz to 1 MHz
	frequency	
	ASK depth	0 to 100 %
	FSK	
	function	sine, rectangle, triangle, ramp
	frequency	0.1 Hz to 1 MHz
	FSK rate	0.1 Hz to carrier frequency/2
Sweep	start frequency	1 Hz to 25 MHz
·	stop frequency	1 Hz to 25 MHz
	sweep time	1 ms to 10 s
	sweep type	linear, logarithmic, triangle
Burst	number of cycle	1 to 1024
	idle time	28 ns to 17 s
	start phase	0° to 360°
	trigger	continuous, manually
1-bit pattern generator	inggor	continuous, manually
<u> </u>		proba adjust/aguara waya bua ajanal
Functions		probe adjust/square wave, bus signal
		source 4-bit counter, programmable 4-b
		pattern
Bus signal source		SPI, I <sup>2</sup> C, UART, CAN, LIN, audio, PWM
	bandwidth	9600 bit/s to 1 Mbit/s
4-bit counter	frequency	25 mHz to 50 MHz
Programmable pattern	sample rate	20 ns to 1 s, up/down
	square wave frequency	1 mHz to 500 kHz
	memory depth	8096 bit per channel
	pattern idle time	50 ns to 1 s
	amplitude	$V_{low} = 0 \text{ V}, V_{high} = 1.5 \text{ V to } 3.3 \text{ V (meas.)}$

I <sup>2</sup> C triggering and decoding Bus configuration	sources for SCL and SDA			
Dus comiguration		shannal 4 shannal 0 shannal 0		
	R&S <sup>®</sup> RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)		
	bit rate	up to 10 Mbps		
	size of address	7 bit or 10 bit		
	size of data	8 bit		
	label list	associate frame identifier with symbolic ID		
Trigger	trigger events	start, stop, restart, missing acknowledge, address (7 bit or 10 bit), data, address and data		
	offset for trigger on data	0 data byte to 4095 data byte		
	data pattern width	up to 3 sequential data byte		
Decode	displayed signals	bus signal, logic signal or both		
	color coding of bus signal	address, data, start, stop, ACK, NACK, error		
	displayed format of address	hex, symbolic ID (label list)		
	displayed format of data	ASCII, binary, decimal or hex		
SPI triggering and decoding				
Bus configuration	sources for CS, CLK, MOSI and MISC	sources for CS, CLK, MOSI and MISO		
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)		
	bit rate	up to 25 Mbps		
	chip select (CS)	active low, active high or missing (SSPI)		
	clock (CLK) slope	rise or fall		
	data symbol size	1 bit to 32 bit		
	idle time for SSPI	12.8 ns to 26.8 ms		
Trigger	trigger events	start of frame, end of frame, bit number, data pattern		
	selectable bit number	0 to 4095		
	offset for trigger on data pattern	0 to 4095 bit		
	data pattern size	1 bit to 32 bit		
Decode	displayed signals	bus signal, logic signal or both		
	color coding of bus signal	data, start, stop, error		
	displayed format of data	ASCII, binary, decimal or hex		
	data decoding	MSB or LSB first		

UART/RS-232/RS-422/RS-485	triggering and decoding		
Bus configuration	source for RX and TX		
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)	
	bit rate	300 bps to 1 Mbps or user-selectable up to 6 Mbps	
	end of frame	timeout	
	signal polarity	idle low, idle high	
	data symbol size	5 bit to 9 bit	
	parity	none, even or odd	
	stop bits	1, 1.5 or 2	
	Idle time	up to 26.8 ms	
Trigger	trigger events	start bit, start of frame, symbol number, any symbol, pattern of symbols, parity error, stop bit error, break	
	offset for trigger on data symbol	0 to 4095 symbols	
	data symbol pattern width	1 to floor (32/symbol size) symbols	
Decode	displayed signals	bus signal, logic signal or both	
	color coding of bus signal	data, start, stop, error, parity	
	displayed format of data	ASCII, binary, decimal or hex	

Bus configuration	signal type	CAN_H, CAN_L
	bit rate	10/20/33.3/50/83.3/100/125/250/500/
		1000 kbps or user-selectable in range
		from 100 bps to 2 Mbps
	sampling point	10 % to 90 % within bit period
	label list	associate frame identifier with symbolic II
Trigger	trigger events	start of frame, frame type, identifier,
		identifier + data, error condition (any
		combination of CRC error, bit stuffing
		error, form error and ACK error)
	identifier setup	frame type (data, remote or both),
	'	identifier type (11 bit or 29 bit);
		condition =, $\neq$ , >, <; identifier selectable
		from label list
	data setup	data pattern up to 8 byte (hex or binary);
		condition =, ≠, >, <
Decode	displayed signals	bus signal, logic signal or both
200000	color coding of bus signal	start of frame, identifier, DLC, data
	ocior ocaling or bac eighten	payload, CRC, ACK, end of frame, error
		frame, overload frame, CRC error, bit
		stuffing error, ACK error
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list
	mamo tablo	errors highlighted in red; frame navigation
		data export as CSV file
Search	search events	frame, error, identifier, identifier + data,
Couron	ocaron events	identifier + error
	frame event setup	start of frame, end of frame, overload
	name event setup	frame, error frame, data ID 11 bit, data ID
		29 bit, remote ID 11 bit, remote ID 29 bit
	error event setup	any combination of CRC error, bit stuffing
	enor event setup	error, form error and ACK error
	identifier setup	frame type (data, remote or both),
	identifier Setup	identifier type (11 bit or 29 bit);
		condition =, $\neq$ , >, <; identifier selectable
		from label list
	data catur	
	data setup	data pattern up to 8 byte (hex or binary); condition =, $\neq$ , >, <
	event table	
	event table	search results displayed as tabulated list;
I IN triggoring and decoding		event navigation
LIN triggering and decoding Bus configuration	version	1.3, 2.x or SAE J2602; mixed traffic is
	VEISIOII	supported
	bit rate	1.2/2.4/4.8/9.6/10.417/19.2 kbps or user-
	DIL TALE	selectable in range from 100 bps to
		5 Mbps
	polority	active high or active low
	polarity label list	associate frame identifier with symbolic IE
	source	associate frame identifier with symbolic it
Triggor		sharmal 4 sharmal 2 sharmal 2
Trigger		
Trigger	R&S®RTA4004	channel 1, channel 2, channel 3,
Trigger	R&S-RTA4004	channel 4, logic channels from D15 to D0
Trigger		channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)
Trigger	trigger events	channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option) start of frame (sync break), identifier,
Trigger		channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option) start of frame (sync break), identifier, identifier + data, wakeup frame, error
Trigger		channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option) start of frame (sync break), identifier, identifier + data, wakeup frame, error condition (any combination of checksum
Trigger	trigger events	channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option) start of frame (sync break), identifier, identifier + data, wakeup frame, error condition (any combination of checksum error, parity error and sync field error)
Trigger		channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option) start of frame (sync break), identifier, identifier + data, wakeup frame, error condition (any combination of checksum error, parity error and sync field error) range from 0d to 63d; condition =, ≠, >, <;
Trigger	trigger events	channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option) start of frame (sync break), identifier, identifier + data, wakeup frame, error condition (any combination of checksum

Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	frame, frame identifier, parity, data
		payload, checksum, error condition
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list,
		errors highlighted in red; frame navigation;
		data export as CSV file
Search	search events	frame, error, identifier, identifier + data,
		identifier + error
	frame event setup	start of frame, wake up
	error event setup	any combination of checksum error, parity
		error and sync field error
	identifier setup	range from 0d to 63d; condition =, ≠, >, <;
		identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary);
		condition =, ≠, >, <
	event table	search results displayed as tabulated list;
		event navigation

Bus configuration	source (data, clock, word/sync)			
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)		
	thresholds	per-channel threshold (analog channels), per-group threshold (logic channels), assisted threshold configuration (find level		
	bit rate	up to 30 Mbps		
	signal type	I <sup>2</sup> S standard, left justified, right justified, TDM		
	polarity	data: active high, active low; clock: rising edge, falling edge; word/sync: normal, inverted		
	word length	2 bit to 32 bit		
	bit order	most significant bit first (MSBF), least significant bit first (LSBF)		
	I <sup>2</sup> S-specific setup			
	first channel	left, right		
	LJ/RJ-specific setup			
	first channel	left, right		
	channel offset	0 to 31 bit		
	TDM-specific setup			
	number of channels	1 to 8		
	channel length	2 bit to 32 bit		
	channel offset	0 to (channel length – word length) bits		
	channel delay	0 to 31 bit		
Trigger	trigger events	data, window, word/sync, error condition		
	data setup	define individual value and condition for each audio channel; condition =, ≠, >, <, inside range, outside range, don't care; trigger when "all" or "any" audio channel conditions are met in single audio frame		
	window setup	audio channel setup same as data setup; user-defined window length up to 4 000 000 000 frames		
	word/sync setup	rising edge, falling edge		
Decode	displayed signals	bus signal, stacked bus signal, logic signa		
	color coding of bus signal	color-coded audio channels		
	displayed format of data	hex, signed decimal, binary, ASCII		
	frame table	decode results displayed as tabulated list with timestamp; frame navigation; data export as CSV file		
	track of audio waveform	displays audio channel content as a waveform that is time-correlated to the source signals; user can activate, scale and position each audio channel individually		

MIL-STD-1553 triggering and decoding			
Protocol configuration	source		
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4	
	bit rate	standard bit rate (1 Mbit/s)	
	polarity	normal, inverted	
	label list	associate frame identifier with symbolic ID	
	auto threshold setup	assisted threshold configuration	
	timing	max response (4 µs to 200 µs)	
- Frigger	trigger event setup	sync, word, command word, status word,	
nigger	trigger event setup	command and data word, error condition	
	sync setup	all words, command/status word, data	
	Syric Setup	word	
	word actus		
	word setup	all words, command word, status word,	
		data word	
	command word setup (type: address/word)	RT address (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); direction (T/R); subaddress (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); data word count (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range)	
	command word setup (type: mode code)	RT address (condition =, ≠, ≥, ≤, in range,	
		out of range); subaddress (0, 31 or either)	
		mode code from labeled dropdown list	
	status word setup	RT address; status flags (message error,	
	·	instrumentation, service request,	
		broadcast command, busy, subsystem	
		flag, dynamic bus control, terminal flag)	
		individually configurable (1, 0, don't care)	
	command and data word setup	transmission type (BC-RT, RT-BC, BC-	
	·	BC, mode code); RT address (condition =	
		≠, ≥, ≤, in range, out of range); subaddres	
		(condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of	
		range); data word count (condition =, ≠, ≥,	
		≤, in range, out of range); data pattern up	
		to 4 words long (condition =, $\neq$ , $\geq$ , $\leq$ , in	
		range, out of range); payload data index	
		(condition =)	
	error condition setup	any combination of sync error, Mancheste	
	citor condition scrap	error, parity error, timing error (see	
		protocol configuration)	
Decode	display signals	bus signal; symbolic ID in bus signal when	
Decode	display signals	label list in use	
	color coding	sync, RT address, subaddress, mode	
	color coding	1 2 1	
	Parlament of data	code, status bit field, data, error condition	
	displayed format of data	hex, decimal, binary, ASCII	
	frame table	decode results displayed as tabulated list,	
		errors highlighted in red; frame navigation	
		data export as CSV file; column with	
		symbolic ID when label list in use	
Search	search events	word, command word, mode code, status	
		word, command and data word, error	
	word setup	command, status, data	
	command word setup	see trigger settings for "command word setup (type: address/word)"	
	mode code setup	see trigger settings for "command word setup (type: mode code)"	
	status word setup	see trigger settings for "status word setup	
	command and data word setup	see trigger settings for "status word setup	
	·	data word setup"	
	error condition setup	all, sync, parity, manchester, timing	

ARINC 429 triggering and deco			
Protocol configuration	source		
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4	
	bit rate	high (100 kbit/s), low (12.5 kbit/s), or user-defined in range 10 kbit/s to 1 Mbit/s	
	polarity	A leg, B leg, normal, inverted	
	label list	associate numeric label with symbolic ID; optional definition of ARINC word format in terms of availability of label-specific SDI and SSM fields	
	auto threshold setup	assisted threshold configuration	
Trigger	trigger event setup	word, label, label and data, error condition transmission interval	
	word setup	word start, word stop	
	label setup	label (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range)	
	data setup	data pattern up to 23 bit long (condition =, ≠, ≥, ≤, in range, out of range); data bit offset; SDI (00,01,10,11); SSM (00,01,10,11); label list can be used to determine availability of trigger properties SSM and SDI for given label value	
	error condition setup	any combination of coding error, parity error, gap error	
	transmission interval setup	label (condition =); SDI (optional); time interval (condition >, <, in range, out of range)	
Decode	display signals	bus signal, logic signal or both; symbolic ID in bus signal when label list in use	
	color coding	word begin, word end, label, SDI, data, SSM, parity, error	
	displayed format of data	hex, decimal, binary, ASCII	
	frame table	decode results displayed as tabulated list, errors highlighted in red; frame navigation data export as CSV file; column with symbolic ID when label list in use	
Search	search events	word, label, label and data, error condition	
	word setup	word start, word stop	
	label setup	see trigger settings for "label setup"	
	data setup	see trigger settings for "data setup"	
	error condition setup	coding error, parity error, gap error, any	

Power analysis			
General description	The R&S®RTA-K31 power analysis option extends the R&S®RTA firm measurement functionality focused on switched mode power supplies DC/DC converters.		
Input	quality	evaluation of power quality at an AC input; measures real power, apparent power, reactive power, power factor and phase angle of power, frequency, crest factor, RMS of voltage and current	
	harmonics	measures up to the 334th harmonic of the incoming line frequency; precompliance checking for IEC 61000-3-2 (A, B, C, D), RTCA DO-160, MIL-STD-1399, max. limit checks	
	inrush current	measures peak inrush current and electrical charge within up to 3 configurable measurement zones to analyze the inrush and post-inrush behavior	
	consumption	long term measurement of consumed power and energy to analyze nonperiodical signals of e.g. standby devices	
Switching/control loop	slew rate	The minimum and maximum slew rate of current or voltage is measured at start and end of the switching cycle.	
	modulation	measures modulation of switching frequency, duty cycle (±) and pulse width	
	dynamic on-resistance	measures resistance of the switching transistor(s) in active state	
Power path	efficiency switching loss	measures input and output power to calculate the efficiency of a power device measures switching loss and conduction	
	Switching loss	loss of a power device	
	safe operating area (SOA)	checks violation of voltage and current limits in which a power device can operate without damage; current versus voltage	
		view (linear or log); violation mask is user- defined and editable in linear and log-log views; save/load of masks; export of mask violation data	
	turn on/off time	measures relationship between AC and DC current, when turning SMPS off and on	
Output	ripple	measures AC components of output voltage or current, AC RMS, mean, period, frequency, duty cycles, min./max./peak-to-peak amplitude	
	spectrum	FFT analysis of output, measurement of frequency peaks	
	transient response	This measurement captures the device behavior between the event of load changes and stabilization; includes peak (voltage, time), settling	
Deskew	automated	time, rise time, overshoot and delay By using the R&S®RT-ZF20 probe deskew and calibration test fixture and Rohde & Schwarz voltage and current probes, the skew between the signals is compensated automatically.	
Zero offset	automated	automatic compensation of input offset	
Reporting	Report data can be saved for every measurement. Report generation using user-selected test results from historical and current tests. Put repeated and/or different measurements in one report. R&S®Oscilloscope Report Creator can be downloaded from Rohde & Schwarz website free-of-charge.		

	Bode plot (does not require R&S®RTA-B6 option)	
Stimulus	frequency mode	single sweep or repeated sweep
	frequency range	10 Hz to 25 MHz
	amplitude mode	fixed or amplitude profile
	amplitude level	20 mV to 10 V into high Z
		10 mV to 5 V into 50 Ω
Input and output sources	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4
Number of test points		10 points to 500 points per decade
Dynamic range		typ. > 70 dB based on 0 dBm
		(630 mV ( $V_{pp}$ )) into 50 $\Omega$ ,
		gain noise < 1 dB, phase noise < 5°
Measurement		dual pair of tracking gain and phase
		cursors
Diagram types	manually changeable vertical window size	parallel display of result window and input
		and output signal view
Result table		navigation and export functions
Scaling	during and after test	auto-scale and manual scaling and
-	-	positioning

Spectrum analysis and spectrogra General	additional displays spectrum traces and/or spe		
Spectrum	sources		
Spectrum	R&S®RTA4004	channel 1, channel 2, channel 3,	
	1140	channel 4	
	setup parameters	center frequency, frequency span,	
	Sotap parameters	automatic RBW, resolution bandwidth,	
		gate position, gate width, vertical scale,	
		vertical position	
	scaling	dBm, dBV, dBµV, V (RMS)	
	span	0.2 Hz to 1.2 GHz	
	resolution bandwidth	span/10 ≥ RBW ≥ span/1000	
	windows	flat top, Hanning, Hamming, Blackman,	
		rectangular	
	trace types	normal, max. hold, min. hold, average	
pectrogram	color	rainbow, temp. color, monochrome	
1arker	peak marker search	standard search	
		parameter: min. level	
		advanced search	
		parameter: min. level, excursion,	
		maximum width, distance to next peak	
	reference marker	selection via index or frequency range	
	markers on peak	up to 100 markers	
	sources	any spectrum trace	
	table	frequency and magnitude, absolute or	
		relative to reference marker	
	marker result display	indicated at wave form: level, frequency	
Cursor	measurements on spectrum traces	level, frequency, level and frequency,	
		V marker	
	additional actions for cursor	coupling of cursors, set to trace, set to	
		screen, track scaling, set next and	
		previous peak	
Spectrogram measurements	two time cursor	t1, t2, delta t, total time, relative time	
		between segments	

# **Ordering information**

Designation	Туре	Order No.
Choose your R&S®RTA4000 base model		T
Oscilloscope, 200 MHz, 4 channels	R&S®RTA4004	1335.7700.04
Base unit (including standard accessories: 500 MHz passive probe p	er channel, power cord)	
Choose your bandwidth upgrade		
Upgrade of R&S®RTA4004 oscilloscopes to 350 MHz bandwidth	R&S®RTA-B243	1335.7846.02
Upgrade of R&S®RTA4004 oscilloscopes to 500 MHz bandwidth	R&S®RTA-B245	1335.7852.02
Upgrade of R&S®RTA4004 oscilloscopes to 1 GHz bandwidth	R&S®RTA-B2410	1335.7869.02
Choose your options		
Mixed signal upgrade for non-MSO models, 400 MHz	R&S®RTA-B1	1335.7823.02
Arbitrary waveform and 4-bit pattern generator	R&S®RTA-B6	1335.7830.02
<sup>2</sup> C/SPI serial triggering and decoding	R&S®RTA-K1	1335.7681.02
JART/RS-232/RS-422/RS-485 serial triggering and decoding	R&S®RTA-K2	1335.7698.02
CAN/LIN serial triggering and decoding	R&S®RTA-K3	1335.7717.02
Audio (I <sup>2</sup> S, LJ, RJ, TDM) triggering and decoding	R&S®RTA-K5	1335.7723.02
MIL-STD-1553 serial triggering and decoding	R&S®RTA-K6	1335.7730.02
ARINC 429 serial triggering and decoding	R&S®RTA-K7	1335.7746.02
Power analysis	R&S®RTA-K31	1335.7769.02
requency response analysis (Bode plot)	R&S®RTA-K36	1335.7975.02
Spectrum analysis and spectrogram	R&S®RTA-K37	1335.7981.02
Application bundle ⁴, consists of the following options: R&S®RTA-K1, R&S®RTA-K2, R&S®RTA-K3, R&S®RTA-K5, R&S®RTA-K6, R&S®RTA-K7, R&S®RTA-K31, R&S®RTA-K36,	R&S <sup>®</sup> RTA-PK1	1335.7775.02
R&S®RTA-K37, R&S®RTA-B6  Application bundle <sup>5</sup> , consists of the following options: R&S®RTA-K1, R&S®RTA-K2, R&S®RTA-K3, R&S®RTA-K5, R&S®RTA-K6, R&S®RTA-K7, R&S®RTA-K31, R&S®RTA-K36, R&S®RTA-K37, R&S®RTA-B6	R&S®RTA-PK1US	1335.7998.02
Choose your additional probes		I
Single-ended passive probes		
500 MHz, 10 MΩ, 10:1, 300 V, 10 pF, 5 mm	R&S®RT-ZP05S	1333.2401.02
500 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S®RT-ZP10	1409.7550.00
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm	R&S®RT-ZP1X	1333.1370.02
Active broadband probes: single-ended	RGO RT-ZI IX	1333.1370.02
1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface	R&S®RT-ZS10E	1418.7007.02
1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button,	R&S®RT-ZS10	1410.4080.02
Rohde & Schwarz probe interface	100 111-2510	1410.4000.02
1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface	R&S®RT-ZS20	1410.3502.02
Active broadband probes: differential		
1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface	R&S®RT-ZD10	1410.4715.02
$1.5~GHz,$ active, differential, $1~M\Omega,~R\&S^{@}ProbeMeter,$ micro button, Rohde & Schwarz probe interface	R&S®RT-ZD20	1410.4409.02
Power rail probe		
2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface	R&S®RT-ZPR20	1800.5006.02
High voltage single-ended passive probes		
250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF	R&S®RT-ZH03	1333.0873.02
400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZH10	1409.7720.02
400 MHz, 1000:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZH11	1409.7737.02

 $<sup>^4</sup>$   $\,$  The R&S^8RTA-PK1 option is not distributed in North America.

<sup>&</sup>lt;sup>5</sup> The R&S®RTA-PK1US option is only distributed in North America.

#### Version 11.00, October 2024

Designation	Туре	Order No.
High voltage probes: differential		
200 MHz, 250:1/25:1, 5 MΩ, 750 V (peak), 300 V CAT III, Rohde & Schwarz probe interface	R&S®RT-ZHD07	1800.2307.02
100 MHz, 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S®RT-ZHD15	1800.2107.02
Rohde & Schwarz probe interface		
200 MHz, 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S®RT-ZHD16	1800.2207.02
Rohde & Schwarz probe interface		
100 MHz, 1000:1/100:1, 40 MΩ, 6000 V (peak), 1000 V CAT III,	R&S®RT-ZHD60	1800.2007.02
Rohde & Schwarz probe interface		
Current probes		
20 kHz, AC/DC, 0.01 V/A and 0.001 V/A, ±200 A and ±2000 A, BNC interface	R&S®RT-ZC02	1333.0850.02
100 kHz, AC/DC, 0.1 V/A, 30 A, BNC interface	R&S®RT-ZC03	1333.0844.02
2 MHz, AC/DC, 0.01 V/A, 500 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC05B	1409.8204.02
interface		
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), BNC interface	R&S®RT-ZC10	1409.7750K02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS),	R&S®RT-ZC10B	1409.8210.02
Rohde & Schwarz probe interface		
50 MHz, AC/DC, 0.1 V/A, 30 A (RMS),	R&S®RT-ZC15B	1409.8227.02
Rohde & Schwarz probe interface		
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), BNC interface	R&S®RT-ZC20	1409.7766K02
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS),	R&S®RT-ZC20B	1409.8233.02
Rohde & Schwarz probe interface		
120 MHz, AC/DC, 1 V/A, 5 A (RMS), BNC interface	R&S®RT-ZC30	1409.7772K02
EMC near-field probes		
Probe set for E and H near-field measurements, 30 MHz to 3 GHz	R&S®HZ-15	1147.2736.02
Logic probe		
400 MHz logic probe, 8 channels	R&S®RT-ZL04	1333.0721.02
Probe accessories		
Probe power supply for R&S®RT-ZC10/20/30	R&S®RT-ZA13	1409.7789.02
External attenuator 10:1, 2.0 GHz, 1.3 pF, 60 V DC,	R&S®RT-ZA15	1410.4744.02
42.4 V AC (peak) for R&S®RT-ZD20/30 probes		
Probe pouch	R&S®RT-ZA19	
Power deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
3D positioner with central tensioning knob for easy clamping and	R&S®RT-ZAP	1326.3641.02
positioning of probes (span width: 200 mm, clamping range: 15 mm)		
Choose your accessories		
Front cover	R&S®RTB-Z1	1333.1728.02
Soft bag	R&S®RTB-Z3	1333.1734.02
Transit case	R&S®RTB-Z4	1335.9290.02
Rackmount kit	R&S®ZZA-RTB2K	1333.1728.02

### Warranty and service

Warranty		
Base unit		3 years
All other items		1 year
Service options		
	Service plans	On demand
Calibration	up to five years 6	pay per calibration
Accredited calibration	up to five years 6	pay per accredited calibration
Warranty and repair	up to five years 6	standard price repair
Contact your Rohde & Schwarz s	ales office for further details.	

<sup>&</sup>lt;sup>6</sup> For extended periods, contact your Rohde & Schwarz sales office.

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